Self Protected High Side Driver with Temperature Shutdown and Current Limit

The NCV8445 is a fully protected High–Side driver that can be used to switch a wide variety of loads, such as bulbs, solenoids and other acuators. The device is internally protected from an overload condition by an active current limit and thermal shutdown.

A diagnostic output reports ON and OFF state open load conditions as well as thermal shutdown.

Features

- Short Circuit Protection
- Thermal Shutdown with Automatic Restart
- CMOS (3.3 V / 5 V) compatible control input
- Open Load Detection in On and Off State
- Diagnostic Output
- Undervoltage and Overvoltage Shutdown
- Loss of Ground Protection
- ESD protection
- Slew Rate Control for Low EMI Switching
- Very Low Standby Current
- NCV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC–Q100 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

Typical Applications

- Switch a Variety of Resistive, Inductive and Capacitive Loads
- Can Replace Electromechanical Relays and Discrete Circuits
- Automotive / Industrial



ON Semiconductor®

www.onsemi.com



PIN CONNECTIONS



FEATURE SUMMARY

Operating Voltage Range	VS	6 to 36	V
R _{DSon} (max), T _J = 25°C	R _{ON}	45	mΩ
Output Current Limit (min)	I _{lim}	6	А

ORDERING INFORMATION

Device	Package	Shipping [†]
NCV8445DR2G	SOIC-8 (Pb-Free)	2500 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.





PIN DESCRIPTION

Pin #	Symbol	Description
1	GND	Ground
2	IN	Logic Level Input
3	STAT	Status Output
4	N/C	No Connection
5	VD	Supply Voltage
6	OUT	Output
7	OUT	Output
8	VD	Supply Voltage

MAXIMUM RATINGS

		V	alue	
Rating	Symbol	Min	Мах	Unit
DC Supply Voltage	VD	-0.3	42	V
Peak Transient Input Voltage (Load Dump 42.5 V, V _D = 13.5 V, R _{LOAD} = 6.5 Ω , ISO7637–2 pulse 5)	V _{peak}		56	V
Input Voltage	V _{in}	-8	8	V
Input Current	l _{in}	-5	5	mA
Output Current (Note 1)	l _{out}	-6	Internally Limited	A
Negative Ground Current	-I _{gnd}	-200	-	mA
Status Current	I _{status}	-5	5	mA
Power Dissipation, $Tc = 25^{\circ}C$	P _{tot}	1.	.183	W
Electrostatic Discharge (HBM Model 100 pF / 1500 Ω) Input Status Output V _D		4 3.5 5 5		DC kV kV kV kV
Single Pulse Inductive Load Switching Energy (Note 2) (L = 1.8 mH, V_{bat} = 13.5 V; I _L = 8.75 A, T _{Jstart} = 150°C)	E _{AS}	101.5		mJ
Operating Junction Temperature	TJ	-40	+150	°C
Storage Temperature	T _{storage}	-55	+150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.
Reverse Output current has to be limited by the load to stay within absolute maximum ratings and thermal performance.
Not subjected to production testing.

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max Value	Unit
Thermal Resistance Junction-to-Lead Junction-to-Ambient (min. Pad) Junction-to-Ambient (1" square pad size, FR-4, 1 oz Cu)	R _{θJL} R _{θJA} R _{θJA}	72 110.8 105.6	°C/W °C/W °C/W

ELECTRICAL CHARACTERISTICS (8 \le V_D \le 36 V; -40°C < T_J < 150°C unless otherwise specified)

				Value		
Rating	Symbol	Symbol Conditions		Тур	Max	Unit
Operating Supply Voltage	VD		6	-	36	V
Undervoltage Shutdown	V _{UV}		3	5	6.5	V
Undervoltage Restart	V _{UV_Rst}				6.5	V
Overvoltage Shutdown	V _{OV}		36			V
On Resistance	R _{ON}	$I_{out} = 2 \text{ A}; T_J = 25^{\circ}\text{C}, V_D > 8 \text{ V}$ $I_{out} = 2 \text{ A}, V_D > 8 \text{ V}$			45 90	mΩ
Standby Current	۱ _D	Off State, $V_{in} = V_{out} = 0 V$, $V_D = 13.5 V$ On State; $V_{in} = 5 V$, $V_D = 13.5 V$, $I_{out} = 0 A$		10 2.0	20 4.0	μA mA
Output Leakage Current	ΙL	$V_{in} = V_{out} = 0 V$ $V_{in} = 0 V, V_{out} = 3.5 V$ $V_{in} = V_{out} = 0 V, V_D = 13.5 V$	-12		10 5 5	μΑ
INPUT CHARACTERISTICS						
Input Voltage – Low	V _{in_low}				1.25	V
Input Current – Low	I _{in_low}	V _{in} = 1.25 V	1			μA
Input Voltage – High	V _{in_high}		3.25			V
Input Current – High	I _{in_high}	V _{in} = 3.25 V			10	μA
Input Hysteresis Voltage	V _{hyst}		0.25		1	V
Input Clamp Voltage	V _{in_cl}	l _{in} = 1 mA l _{in} = −1 mA	12 -14	13 –13	14 –12	V
SWITCHING CHARACTERISTI	cs			•		
Turn-On Delay Time	t _{d_on}	to 10% V _{out} , V _D = 13.5 V, R _L = 6.5 Ω	5.0	30	55	μs
Turn-Off Delay Time	t _{d_off}	to 90% V _{out} , V _D = 13.5 V, R _L = 6.5 Ω	35	60	85	μs
Slew Rate On	dV _{out} / dt _{on}	10% to 80% V_{out},V_{D} = 13.5 V, R_{L} = 6.5 Ω	0.1	0.4	0.8	V / με
Slew Rate Off	dV _{out} / dt _{off}	90% to 10% V_{out},V_{D} = 13.5 V, R_{L} = 6.5 Ω	0.1	0.5	0.8	V / με
OUTPUT DIODE CHARACTER	STICS (Note 3)					
Forward Voltage	V _F	I _{out} = −1.3 A, T _J = 150°C			0.6	V
STATUS PIN CHARACTERISTI	cs					
Status Output Voltage Low	V _{stat_low}	I _{stat} = 1.6 mA		0.2	0.5	V
Status Leakage Current	I _{stat_leakage}	V _{stat} = 5 V	1	0.3	2.0	μA
Status Pin Input Capacitance	C _{stat}	V _{stat} = 5 V (Note 3)	1	1	100	pF
Status Clamp Voltage	V _{stat_cl}	I _{stat} =1 mA I _{stat} = -1 mA	10 -2.2	11 -1.2	13 -0.6	V
PROTECTION FUNCTIONS (No	ote 4)					
Temperature Shutdown (Note 3)	T _{SD}		150	175	200	°C
Temperature Shutdown Hysteresis (Note 3)	T _{SD_hyst}		7	15		°C
Output Current Limit	I _{lim}	8 V < V _D < 36 V	9	15	24	Α
		6 V < V _D < 36 V	6	11	18	Α
Status Delay in Overload (Note 3)	t _{d_stat}				20	μs
Switch Off Output Clamp Voltage	V _{clamp}	$I_{out} = 2 A, V_{in} = 0 V, L = 6 mH$	V _D - 43	V _D - 46	V _D – 50	V

Not subjected to production testing
 To ensure long term reliability under heavy overload or short circuit conditions, protection and related diagnostic signals must be used together with a proper hardware/software strategy. If the devices operates under abnormal conditions this hardware/software solutions must limit the duration and number of activation cycles.

ELECTRICAL CHARACTERISTICS (8 \le V_D \le 36 V; -40°C < T_J < 150°C unless otherwise specified)

			Value		Value	
Rating	Symbol	Conditions	Min	Тур	Max	Unit
DIAGNOSTICS CHARACTERIS	TICS					
Openload On State Detection Threshold	I _{OL}	V _{in} = 5 V	30		500	mA
Openload On State Detection Delay	t _{d_OL_on}	$I_{out} = 0 A$		100	200	μs
Openload Off State Detection Threshold	V _{OL}	V _{in} = 0 V	1.5	2.4	3.5	V
Openload Detection Delay at Turn Off	t _{d_OL_off}			150	350	μs

3. Not subjected to production testing

 To ensure long term reliability under heavy overload or short circuit conditions, protection and related diagnostic signals must be used together with a proper hardware/software strategy. If the devices operates under abnormal conditions this hardware/software solutions must limit the duration and number of activation cycles.

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.





Figure 2. Open Load Status Timing (with external pull-up)

Figure 3. Overtemperature Status Timing



Figure 4. Switching Timing Diagram

STATUS PIN TRUTH TABLE

Conditions	Input	Output	Status
Normal Operation	L	L	H
	H	H	H
Undervoltage	LH	L	x x
Overvoltage	L H	L	н н
Current Limitation	L	L	H
	H	X	(T _J < T _{SD}) H
	H	X	(T _J > T _{SD}) L
Overtemperature	L H	L	H L
Output Voltage > V _{OL}	L	H	L
	H	H	H
Output Current < I _{OL}	L	L	H
	H	H	L









TYPICAL CHARACTERISTICS CURVES





ISO 7637-2: 2004(E) PULSE TEST RESULTS

ISO 7637-2:2004(E)		Test Levels				
Test Pulse	I	II	III	IV	Impedance	
1	–25 V	–50 V	–75 V	–100 V	2 ms, 10 Ω	
2a	+25 V	+50 V	+37 V	+50 V	0.05 ms, 10 Ω	
3a	–25 V	–50 V	–112 V	–150 V	0.1 μs, 50 Ω	
3b	+25 V	+50 V	+75 V	+100 V	0.1 μs, 50 Ω	
4	-4 V	–5 V	-6 V	–7 V	5 s, .01 Ω	
5 (Load Dump)	+26.5 V	+46.5 V	+66.5 V	+86.5 V	400 ms, 2 Ω	

ISO 7637–2:2004(E)		Test Results		
Test Pulse	I	II	III	IV
1	С	С	С	С
2a	С	С	С	С
За	С	С	С	С
3b	С	С	С	С
4	С	С	С	С
5 (Load Dump)	С	E	E	E

Class	Functional Status
A	All functions of a device perform as designed during and after exposure to disturbance.
В	All functions of a device perform as designed during exposure. However, one or more of
	them can go beyond specified tolerance. All functions return automatically to within normal
	limits after exposure is removed. Memory functions shall remain class A.
С	One or more functions of a device do not perform as designed during exposure but return
	automatically to normal operation after exposure is removed.
D	One or more functions of a device do not perform as designed during exposure and do not return to normal operation until exposure is removed and the device is reset by simple
E	One or more functions of a device do not perform as designed during and after exposure and cannot be returned to proper operation without replacing the device.



Figure 30. Waveforms



Figure 31. Application Diagram

Reverse Battery Protection

An external resistor R_{GND} is required to adequately protect the device from a Reverse Battery event. The resistor value can be calculated using the following two formulas.

1. $R_{GND} \ge 600 \text{ mV} / (I_d \text{ (on) max})$

2. $R_{GND} \ge (-V_D) / (-I_{gnd})$

Maximum (I_{gnd}) current, which is the reverse GND pin current, can be found in the Maximum Ratings section. Several High Side Devices can share same the reverse battery protection resistor. Please note that the sum of (I_d (on) max) of all devices should be used to calculate R_{GND} value. If the microprocessor ground is not common with the device ground, R_{GND} will produce a voltage offset ((I_d (on) max) x R_{GND}) with respect to the IN and STAT pins. This offset will be increased when more than one device shares the resistor.

Power Dissipation during a reverse battery event is equal to:

$$\mathsf{P}_\mathsf{D} = \left(-\mathsf{V}_\mathsf{D}\right)^2 / \mathsf{R}_\mathsf{GND}$$

In the case of high power dissipation due to several devices sharing R_{GND} , it is recommended to place a diode D_{GND} in the ground path as an alternate reverse battery protection method. When driving an inductive load, a 1 k Ω resistor should be placed in parallel with the D_{GND} diode. This method will also produce a voltage offset of ~600 mV with respect to the IN and STAT pins. This diode can also be shared amongst several High Side Devices. This voltage offset will vary if D_{GND} is shared by multiple devices.



Figure 32. Open Load Detection In Off State

OFF State Open Load Detection

Off State Open Load Detection requires an external pull-up resistor ($R_{pull-up}$) connected between V_{OUT} pin and a positive supply voltage ($V_{pull-up}$).

The external $R_{pull-up}$ resistor value should be selected to ensure that a false OFF State OL condition is not detected when the load (R_L) is connected. A V_{OUT} voltage above the V_{OL_min} (Openload Off State Detection Threshold) minimum value with the load (R_L) connected needs to be avoided. The following formula shows this relationship:

$$V_{OUT} = \left(V_{pull-up} / \left(R_{L} + R_{pull-up}\right)\right) R_{L} < V_{OL_min}$$

In addition to ensuring the selected $R_{pull-up}$ resistor value does not cause a false OFF State OL detection condition

when the load is connected, the $R_{pull-up}$ must also not cause the OFF State OL to miss detecting an OL condition when the load is disconnected. A V_{OUT} voltage below the V_{OL_max} (Openload Off State Detection Threshold) maximum value with the load (R_L) disconnected needs to be avoided. The following formula shows this relationship:

$$R_{pull-up} < (V_{pull-up} - V_{OL_max})/OL_1$$
$$OL_1 = I_L (Output Leakage with V_{OUT} = 3.5 \text{ V})$$

Because I_d (OFF) may significantly increase if V_{OUT} is pulled high (up to several mA), $R_{pull-up}$ resistor should be connected to a supply that is switched OFF when the module is in standby.



Figure 33. Transient Thermal Impedance



PACKAGE DIMENSIONS



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

ON Semiconductor and 💷 are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typical" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and hold ON Semiconductor and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that ON Semiconductor was negligent regarding the design or manufacture of the part. ON Semiconductor is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT

Literature Distribution Center for ON Semiconductor 19521 E. 32nd Pkwy, Aurora, Colorado 80011 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com

N. American Technical Support: 800-282-9855 Toll Free USA/Canada Europe, Middle East and Africa Technical Support:

Phone: 421 33 790 2910 Japan Customer Focus Center Phone: 81-3-5817-1050

ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative

- ANSI Y14.5M, 1982. CONTROLLING DIMENSION: MILLIMETER.
- DIMENSION A AND B DO NOT INCLUDE MOLD PROTRUSION. 3
- MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE
- DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL 5 IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION.
- 6. 751-01 THRU 751-06 ARE OBSOLETE. NEW STANDARD IS 751–07

	MILLIMETERS		INC	HES			
DIM	MIN MAX		MIN	MAX			
Α	4.80	5.00	0.189	0.197			
В	3.80	4.00	0.150	0.157			
c	1.35	1.75	0.053	0.069			
D	0.33	0.51	0.013	0.020			
G	1.27	7 BSC	0.050 BSC				
Н	0.10	0.25	0.004	0.010			
J	0.19	0.25	0.007	0.010			
κ	0.40	1.27	0.016	0.050			
Μ	0 °	8 °	0 °	8 °			
Ν	0.25	0.50	0.010	0.020			
0	5.80	6.20	0.228	0.244			